Notice of References Cited

Application/Control No.

10/750,278

Applicant(s)/Patent Under Reexamination VERDIELL, JEAN-MARC

Examiner

Dzung D. Tran

Applicant(s)/Patent Under Reexamination VERDIELL, JEAN-MARC

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0076559	04-2003	Richard et al.	359/123
*	В	US-2003/0108353	06-2003	Nasu et al.	398/91
*	С	US-2002/0154857	10-2002	Goodman et al.	385/24
*	D	US-2003/0048513	03-2003	Bloom et al.	359/152
*	E	US-6,493,121	12-2002	Althaus, Hans-Ludwig	398/135
	F	US-			
	G	US-			
	н	US-			
	1	US-			
	J	US-		***************************************	
	К	US-		·	
100	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	P					
	Q					
	R	,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,				
	s					
	Т				·	

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.